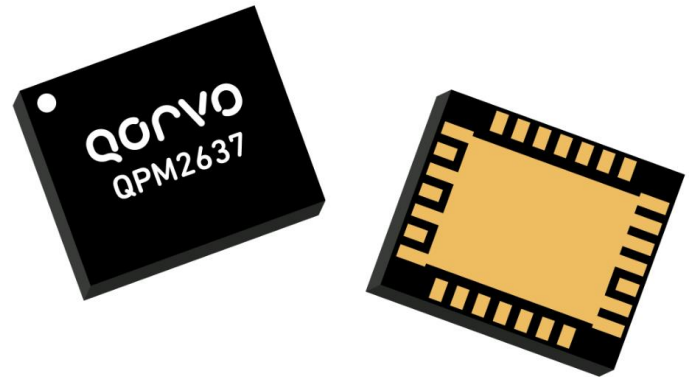


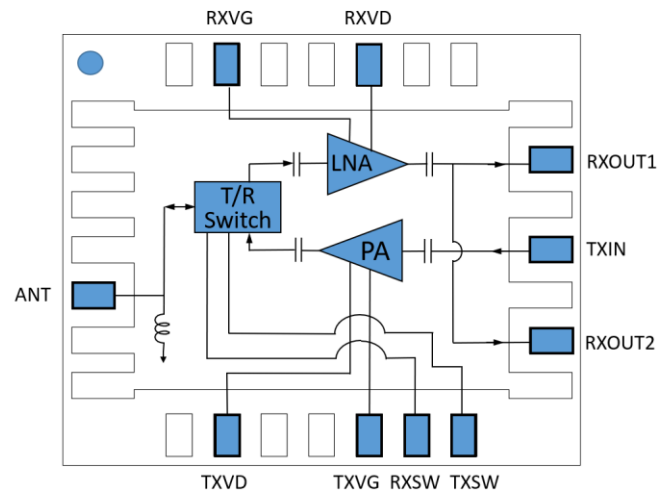
### Product Description

The QPM2637 is a Gallium Nitride MMIC front-end module (FEM) designed for X-Band radar applications within the 9-10.5 GHz range. The MMIC combines a T/R switch, low-noise amplifier, and a power amplifier. The receive path has dual-outputs which offer 21dB gain and 2.7dB noise figure. The transmit path delivers 4W of saturated power with 23dB large signal gain. The FEM is a high robustness device with up to 4W of input power into the ANT port eliminating the need for a limiter.

The QPM2637 is fabricated on Qorvo's QGaN25 0.25um GaN-on-SiC process. The air-cavity EHS (embedded copper heat slug) surface mount package, coupled with a low thermal resistance die-attach process, allows the QPM2637 to perform well at extreme case temperatures. Its compact size supports tight lattice spacing requirements needed for X-Band phased array radar applications.



### Functional Block Diagram



### Product Features

- Frequency Range: 9 – 10.5 GHz
- RX Noise Figure: 2.7 dB
- RX Small Signal Gain: 21 dB
- RX OTOI : 21 dBm
- TX Large Signal Gain: 23 dB
- TX Saturated Power: 36 dBm, Pulsed
- TX PAE: 38% @ 36 dBm Pout, Pulsed
- Package Dimensions: 6 x 5 x 1.8 mm
- Switching Time: < 35 nS

*Performance is typical at room temperature.  
Please reference electrical specification table and data plots for more details.*

### Applications

- Electronics Warfare (EW)
- Commercial and Military Radar
- Communications

### Ordering Information

| Part No.   | Description                     |
|------------|---------------------------------|
| QPM2637    | QPM2637, Shipping Tray, Qty 10  |
| QPM2637TR7 | QPM2637, Tape and Reel, Qty 250 |
| QPM2637EVB | QPM2637 Evaluation Board, Qty 1 |

## Normal Operating Conditions

| Parameter                                 | Value      | Units |
|---|------------|-------|
| RX Drain Voltage (RXVD)                   | 10         | V     |
| RX Drain Quiescent Current (RXIDQ)        | 30         | mA    |
| RX Gate Control (RXVG)                    | -2.5       | V     |
| TX Drain Voltage (TXVD)                   | 28         | V     |
| TX Drain Quiescent Current (TXIDQ)        | 50         | mA    |
| TX Gate Voltage (TXVG)                    | -2.5       | V     |
| TX Gate Current (TXIDQ, normal operation) | 25         | mA    |
| Control Voltage (TXSW / RXSW)             | 0 or -28   | V     |
| Operating Temperature Range               | -55 to 100 | °C    |

Gate voltage shown are typical, can be adjusted to set required drain current. Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

## Absolute Maximum Ratings

| Parameter                            | Min Value | Max Value | Units |
|--------------------------------------|-----------|-----------|-------|
| Drain Voltage (TXVD and RXVD)        | -         | 32        | V     |
| Drain Current (TXID)                 | -         | 600       | mA    |
| Drain Current (RXID)                 | -         | 60        | mA    |
| Gate Voltage (RXVG, TXVG)            | -5        | 0         | V     |
| Gate Current (RXIG)                  | -         | 20        | mA    |
| Gate Current (TXIG)                  | -         | 100       | mA    |
| Switch Control Voltage (TXSW, RXSW)  | -50       | 0         | V     |
| Switch Control Current               | -         | 20        | mA    |
| RF Input Power (All RF ports, 85 °C) | -         | 36        | dBm   |
| Channel Temperature, T <sub>CH</sub> | -         | 225       | °C    |
| Mounting Temperature (30 seconds)    | -         | 260       | °C    |
| Storage Temperature                  | -55       | 150       | °C    |

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability.

## Electrical Specifications, Receive

Test conditions unless otherwise noted: 25 °C, RXVD = 10 V, RXIDQ = 30 mA, RXSW = -28 V, TXSW = 0 V, PA off.  
Data de-embedded to device reference plane

| Parameter  | Min   | Typical | Max  | Units |
|--|-------|---------|------|-------|
| Frequency  | 9     |         | 10.5 | GHz   |
| Small Signal Gain  |       | 21      |      | dB    |
| Noise Figure   |       | 2.7     |      | dB    |
| Input Return Loss  |       | 10      |      | dB    |
| Output Return Loss   |       | 23      |      | dB    |
| Output TOI   |       | 21      |      | dBm   |
| Gate Leakage Current (RXVG Leak)<br>(RXVD = 10 V, RXVG = -3.7 V, RXSW = -28 V, TXSW = -28 V) | -0.55 | -0.01   |      | mA    |
| Switch Settling Time, Rising Edge <sup>1</sup>   |       | 5       |      | nS    |
| Switch Settling Time, Falling Edge <sup>2</sup>  |       | 35      |      | nS    |
| Gain Temperature Coefficient   |       | -0.038  |      | dB/°C |

1 From 50% trigger signal to 90 % of RF on (Trigger signal to switch driver to DUT)

2 From 50% trigger signal to 10 % of RF off (Trigger signal to switch driver to DUT)

## Electrical Specifications, Transmit

Test conditions unless otherwise noted: 25 °C, TXVD = 28 V, TXIDQ = 50 mA, RXSW = 0 V, TXSW = -28 V, LNA off.  
Data de-embedded to device reference plane

| Parameter  | Min  | Typical | Max  | Units |
|--|------|---------|------|-------|
| Frequency  | 9    |         | 10.5 | GHz   |
| Large Signal Gain  |      | 23      |      | dB    |
| Input Return Loss  |      | 15      |      | dB    |
| Output Return Loss   |      | 8       |      | dB    |
| Saturated Output Power <sup>1</sup>  |      | 36      |      | dBm   |
| PAE at Saturated Power (@ 13 dBm Pin)  |      | 42      |      | %     |
| Harmonic Suppression up to Saturated Power   |      | 30      |      | dBc   |
| Gate Leakage Current (TXVG Leak)<br>(TXVD = 10 V, RXVG = -3.7 V, RXSW = -28 V, TXSW = -28 V) | -2.2 | -0.01   |      | mA    |
| Switch Settling Time, Rising Edge <sup>2</sup>   |      | 30      |      | nS    |
| Switch Settling Time, Falling Edge <sup>3</sup>  |      | 8       |      | nS    |
| Gain Temperature Coefficient   |      | -0.045  |      | dB/°C |

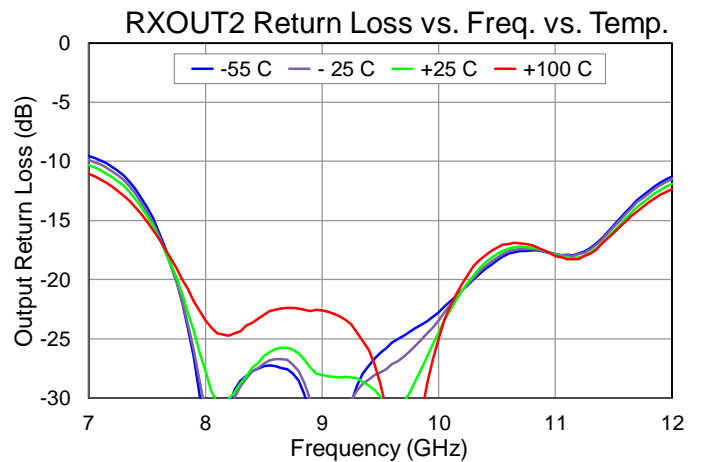
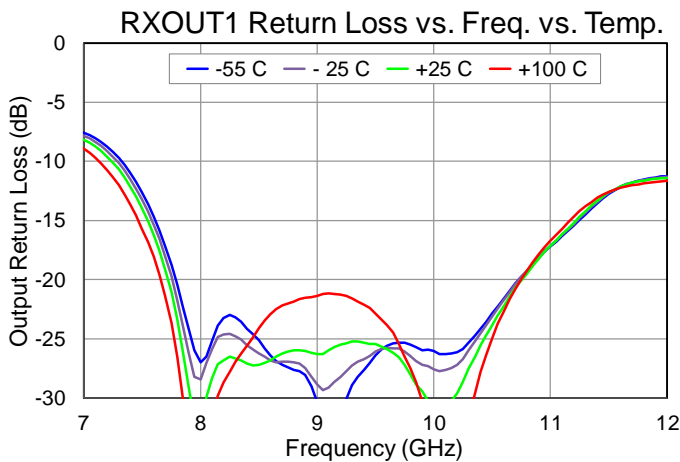
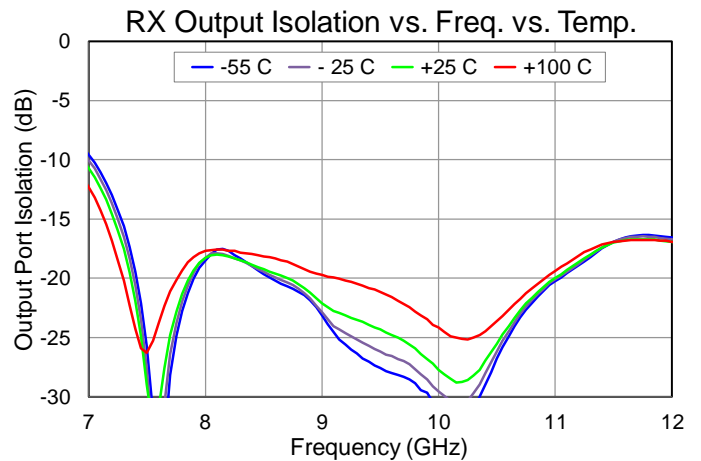
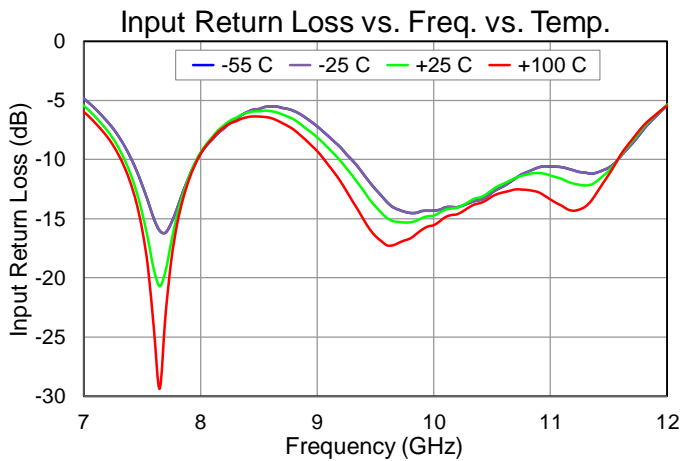
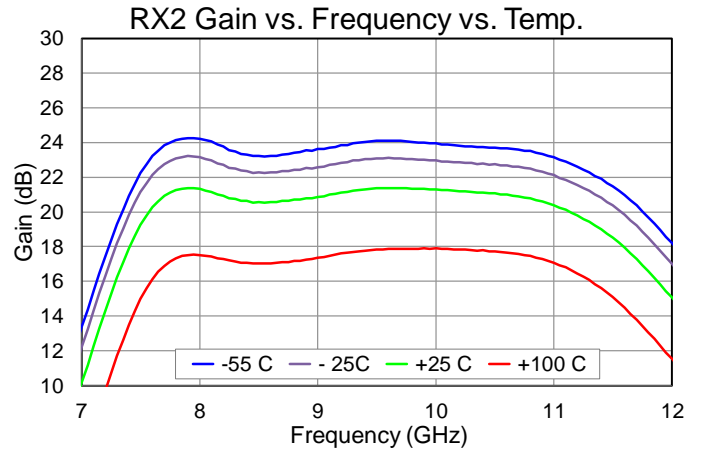
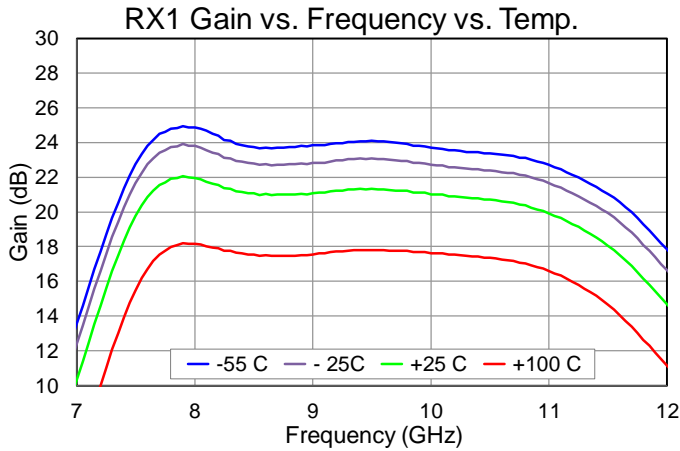
1. Power and PAE measured with DC drain pulsed, PW = 200 uS, Duty Cycle = 10%

2. From 50% trigger signal to 90 % of RF on (Trigger signal to switch driver to DUT)

3. From 50% trigger signal to 10 % of RF off (Trigger signal to switch driver to DUT)

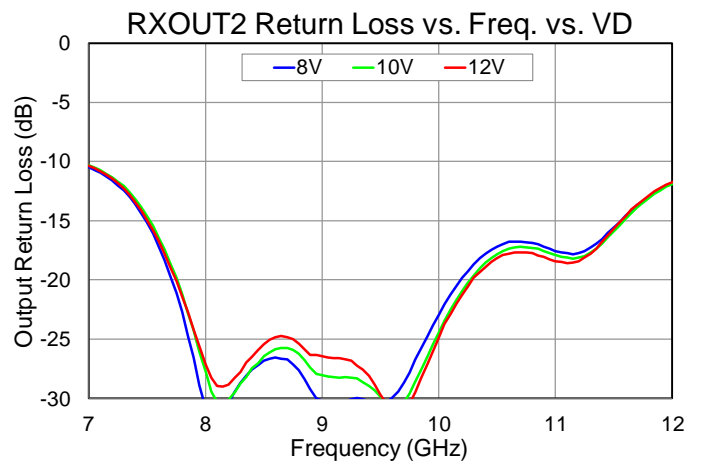
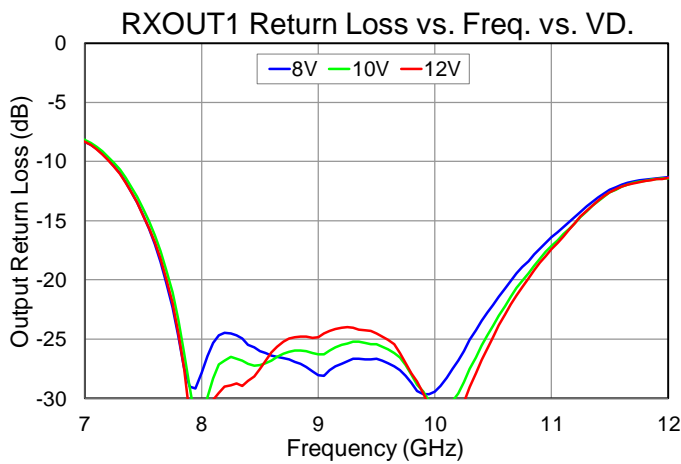
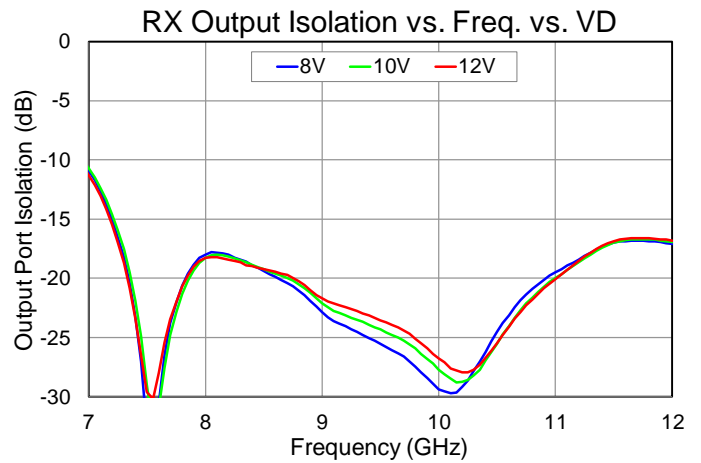
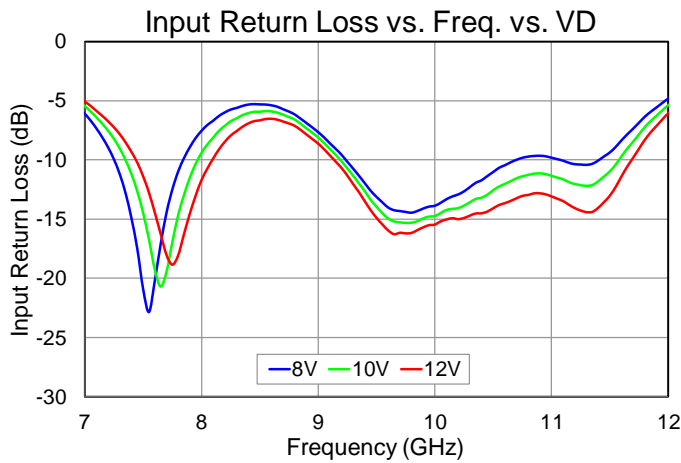
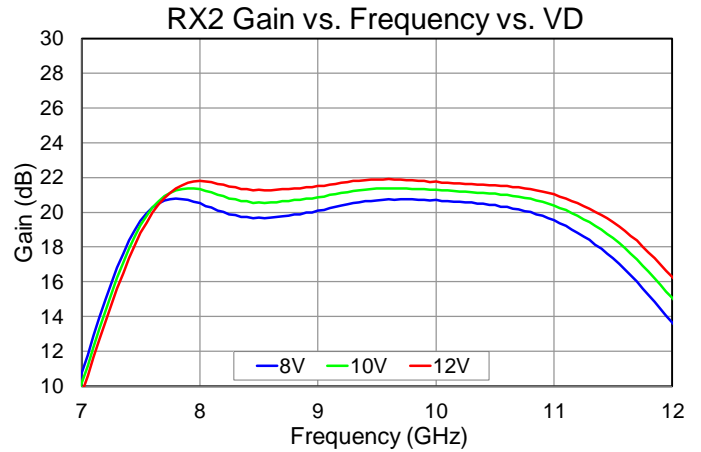
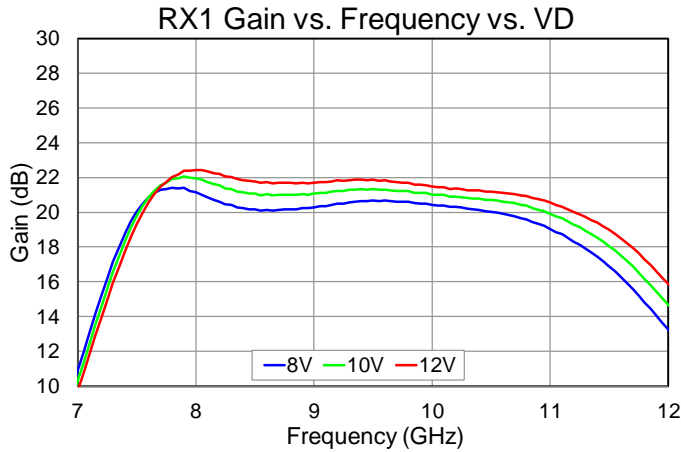
## Performance Plots, Receive Channel

Test Conditions unless otherwise stated: RXVD = 10 V, RXIDQ = 30 mA, RXSW = - 28 V, TXSW = 0 V, PA off, 25C  
Data de-embedded to device reference plane, Port 1: Common Port, Port 2: RXOUT1, Port 3: RXOUT2



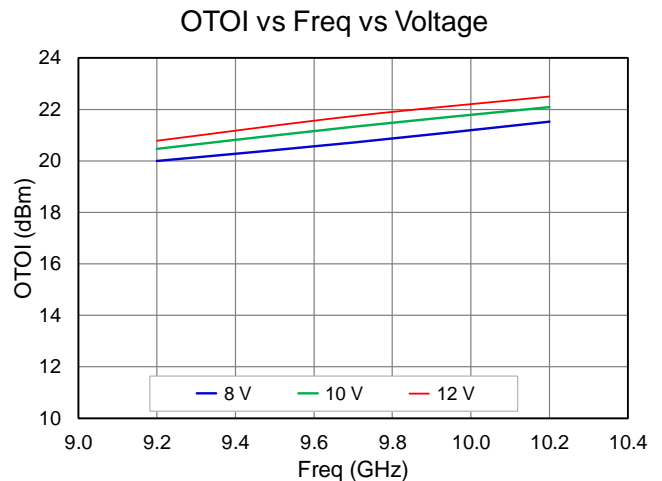
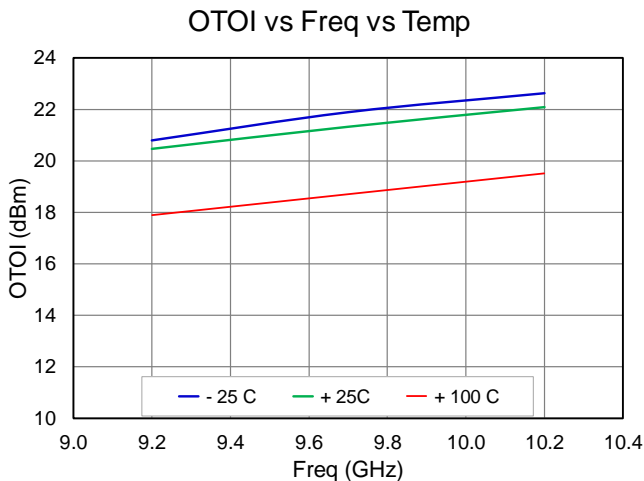
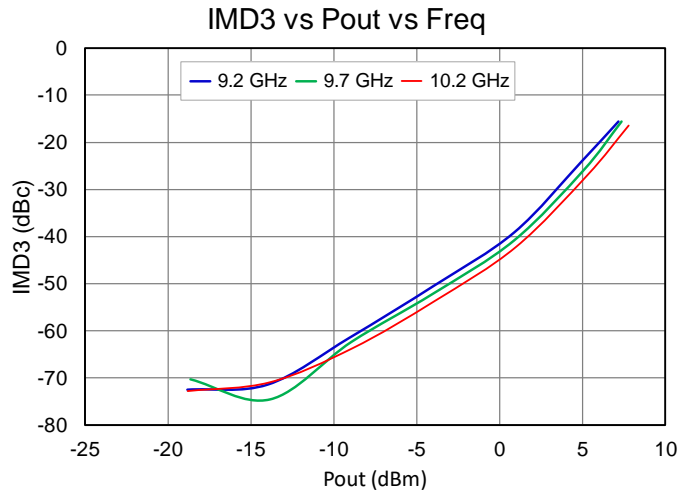
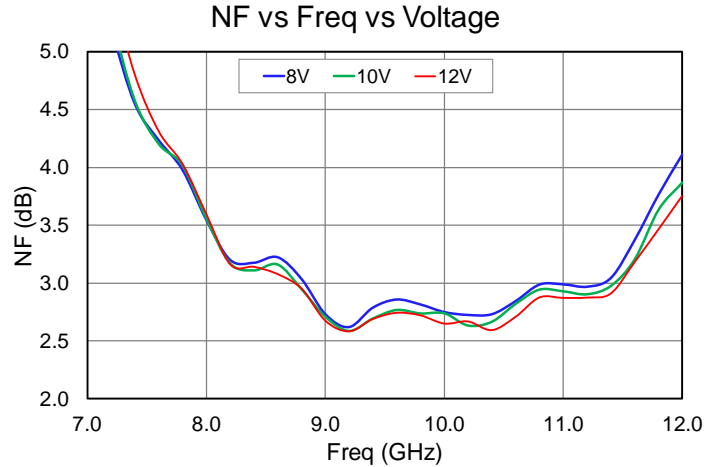
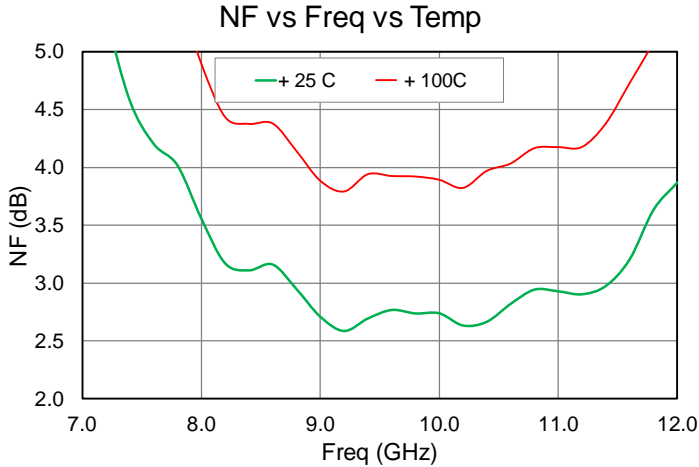
## Performance Plots, Receive Channel

Test Conditions unless otherwise stated: RXVD = 10 V, RXIDQ = 30 mA, RXSW = -28 V, TXSW = 0 V, PA off, 25C  
Data de-embedded to device reference plane, Port 1: Common Port, Port 2: RXOUT1, Port 3: RXOUT2



## Performance Plots, Receive Channel

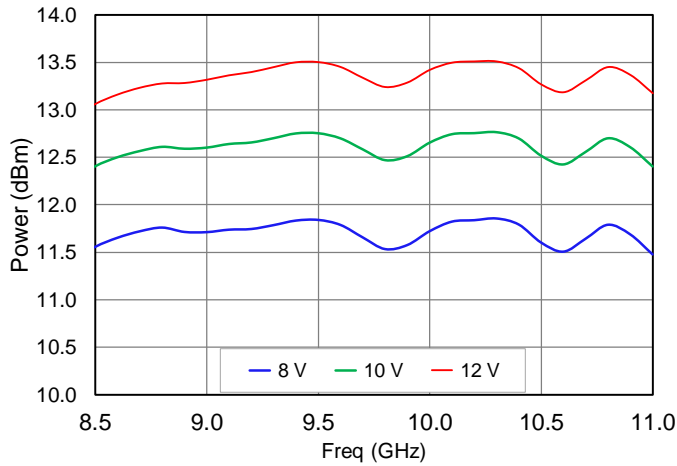
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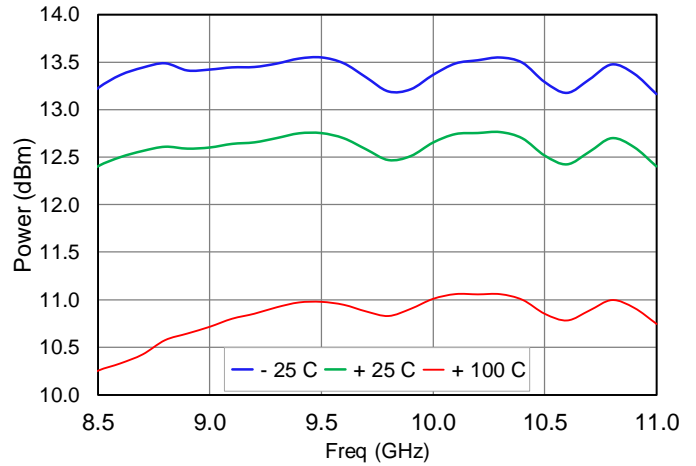
## Performance Plots, Receive Channel

Test Conditions unless otherwise stated:  $V_D = 10\text{ V}$ ,  $R_{XIDQ} = 30\text{ mA}$ ,  $P_{in} = 5\text{ dBm}$ ,  $R_{XSW} = -28\text{ V}$ ,  $T_{XSW} = 0\text{ V}$ , PA off  
Data de-embedded to device reference plane, 25C

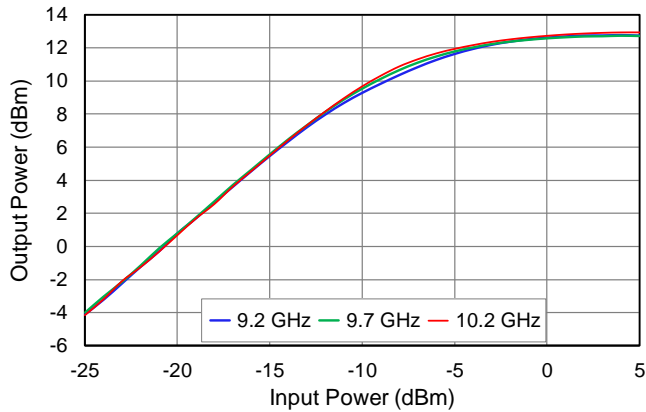
RX Psat vs Freq vs Voltage



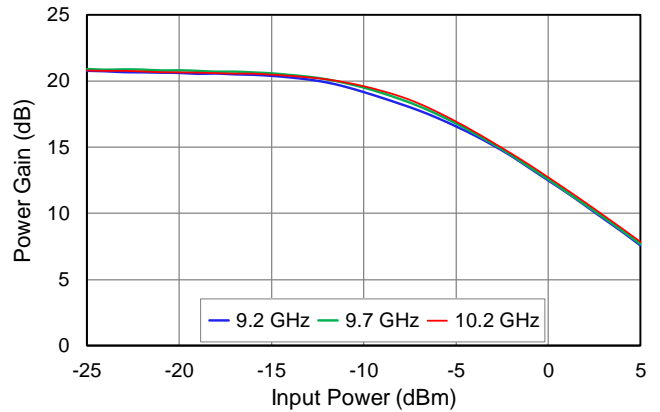
RX Psat vs Freq vs Temp



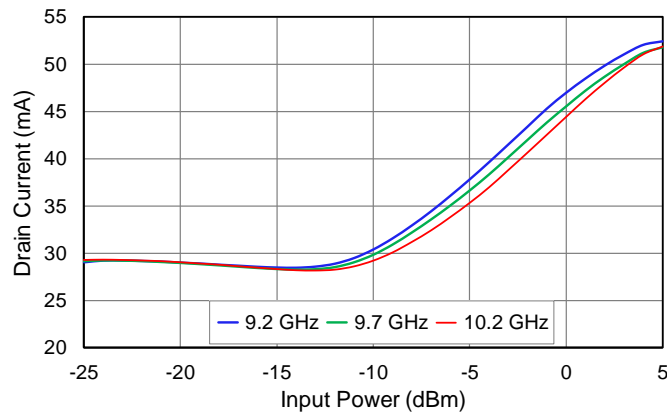
Output Power vs Pin vs Freq



Power Gain vs Pin vs Freq

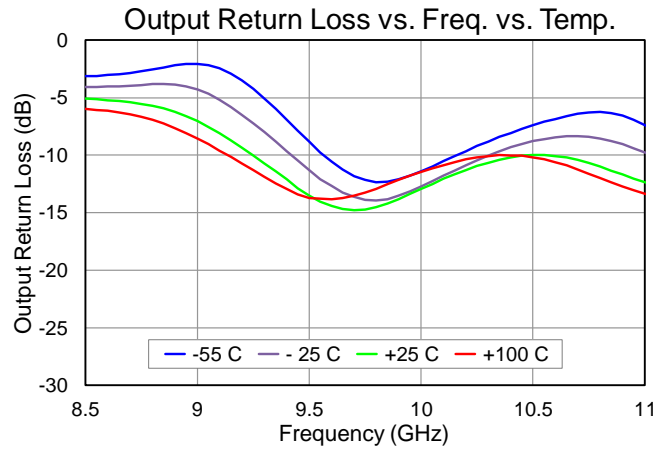
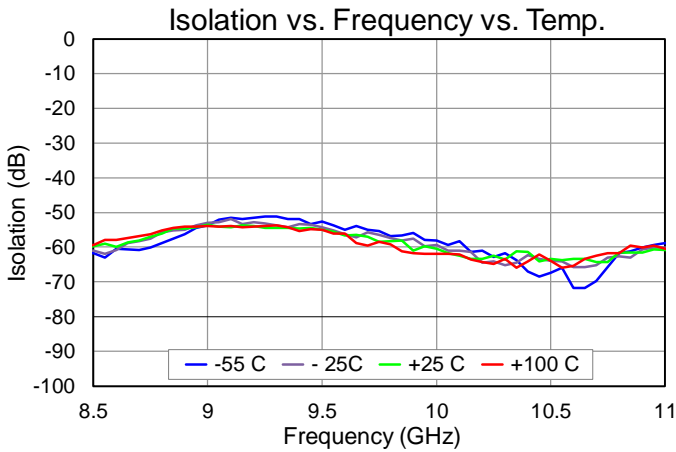
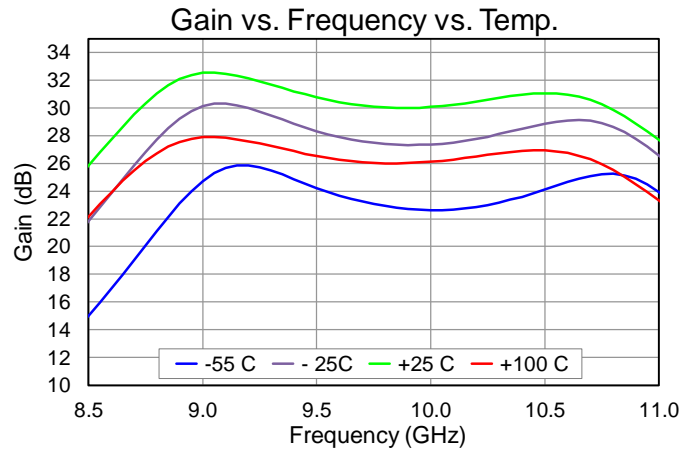
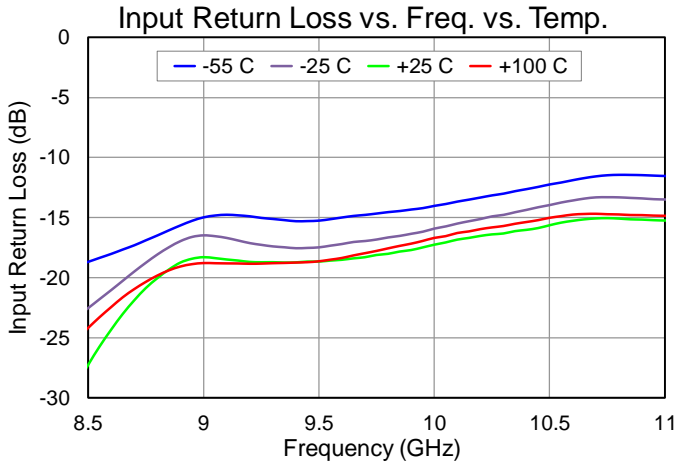


Drain Current vs Pin vs Freq



## Performance Plots, Transmit Channel

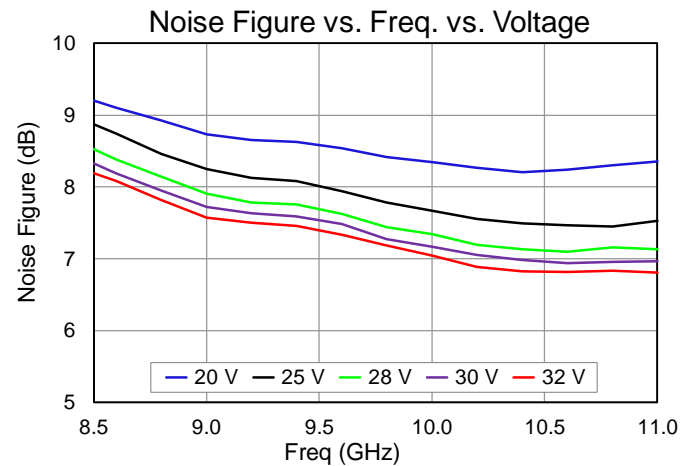
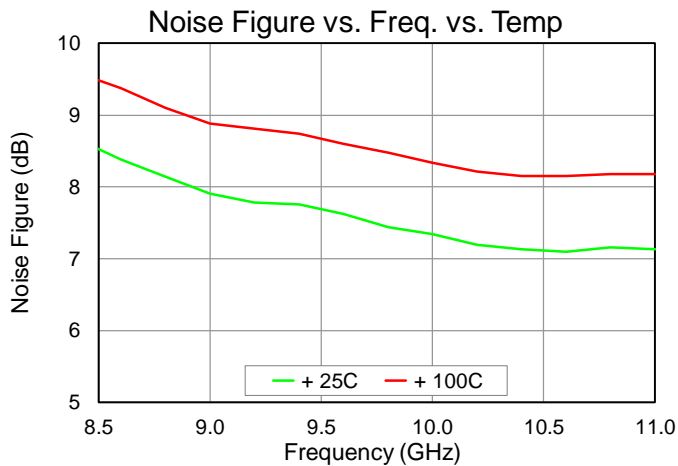
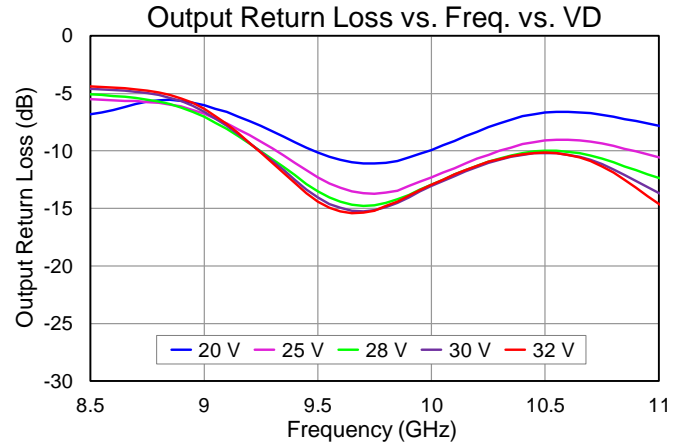
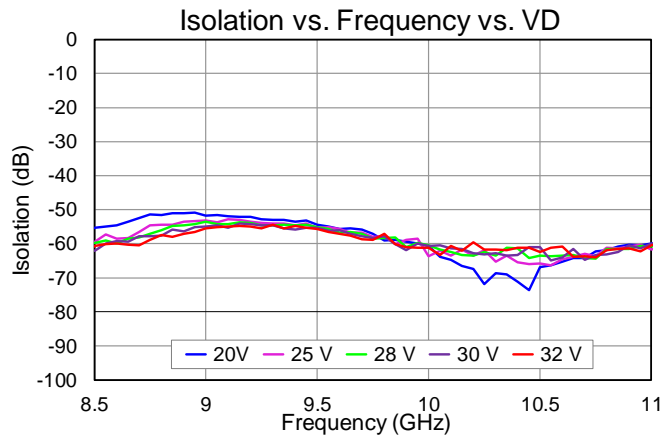
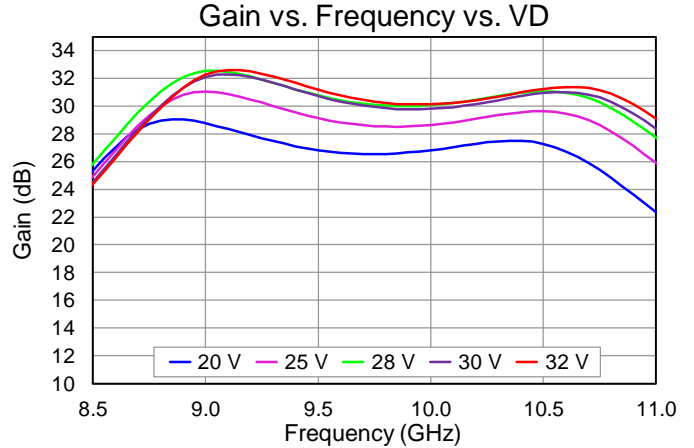
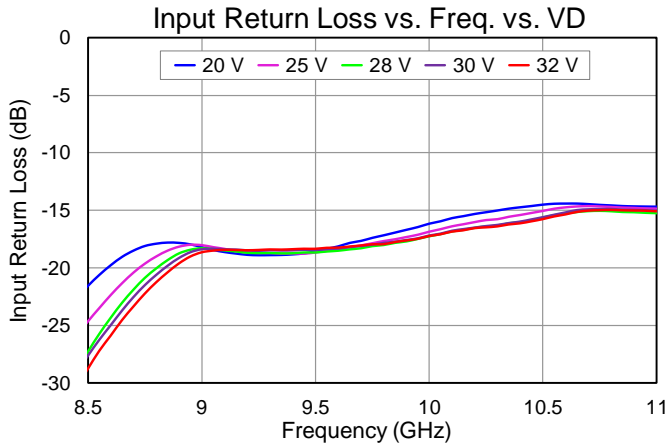
Test Conditions unless otherwise stated: TXVD = 28 V, TXIDQ = 50 mA, TXVG fixed over temperature  
RXSW = 0V, TXSW = -28 V, LNA off. Data de-embedded to device reference plane, 25C





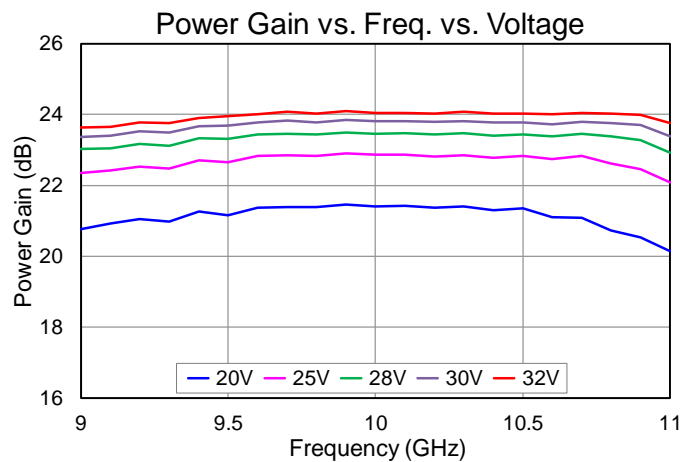
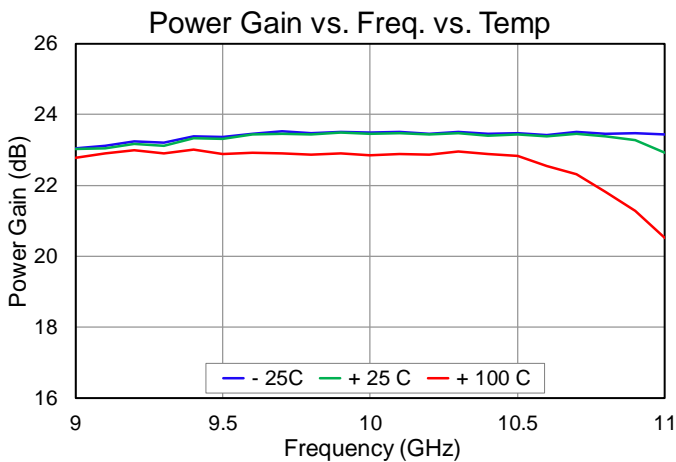
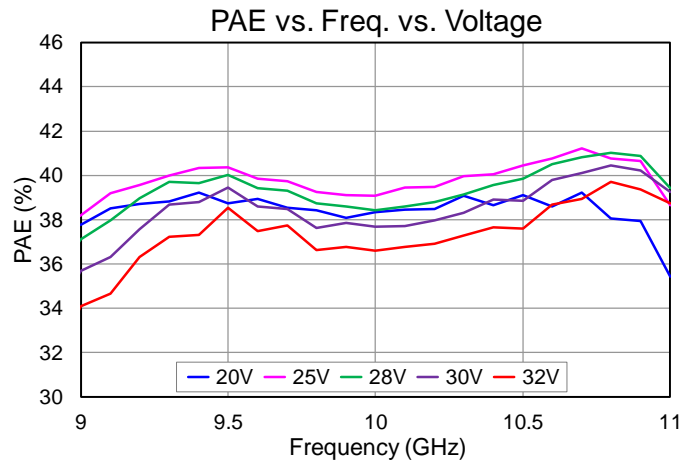
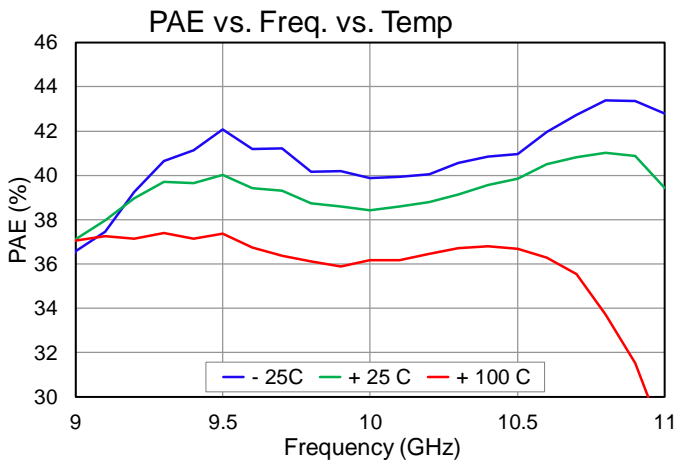
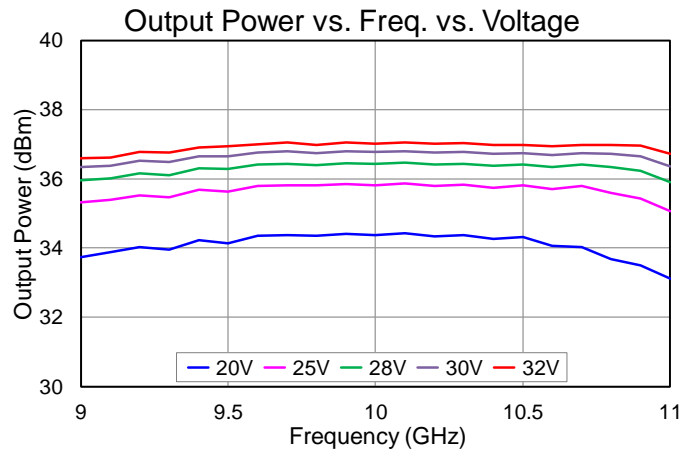
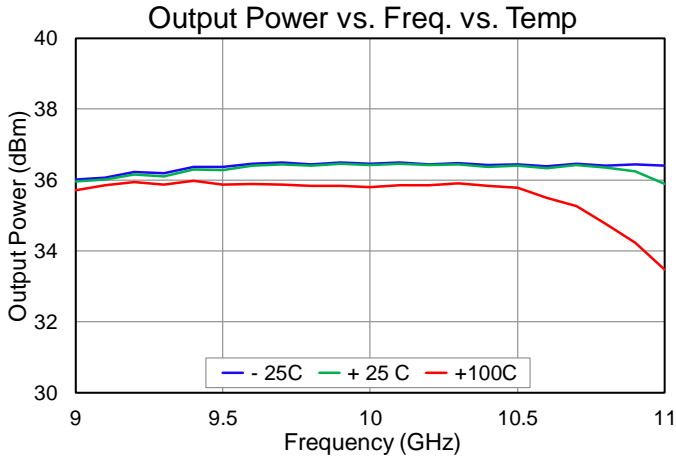
## Performance Plots, Transmit Channel

Test Conditions unless otherwise stated: VD = 28 V, TXIDQ = 50 mA, TXVG fixed over temperature  
RXSW = 0V, TXSW = -28 V, LNA off. Data de-embedded to device reference plane, 25C



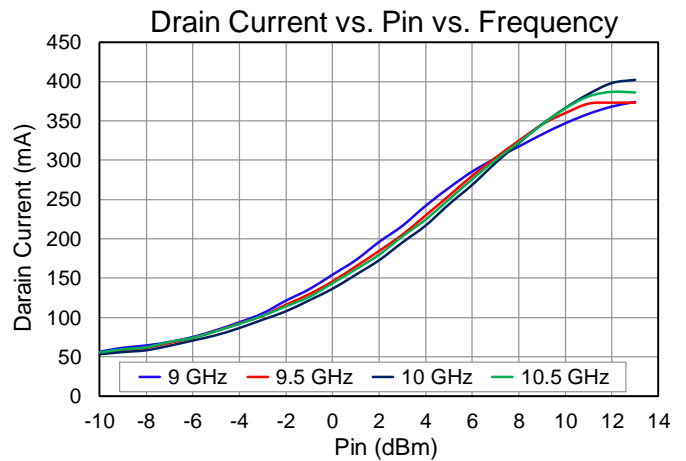
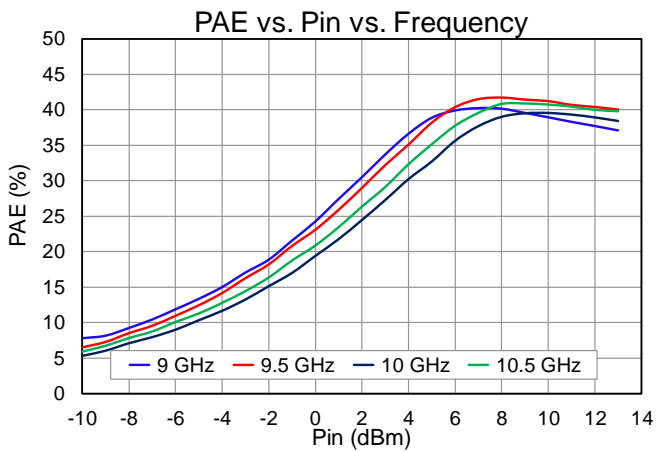
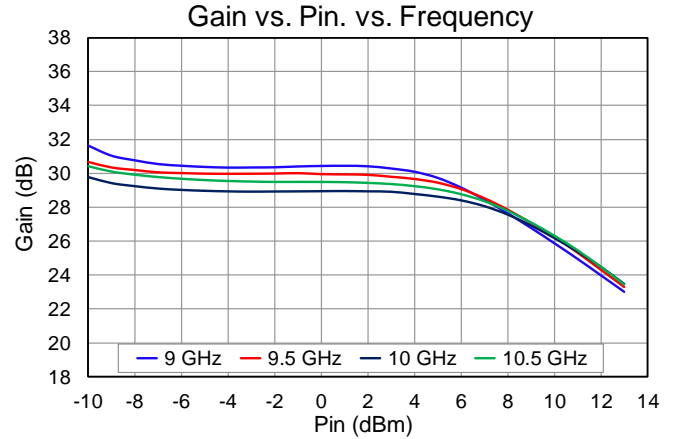
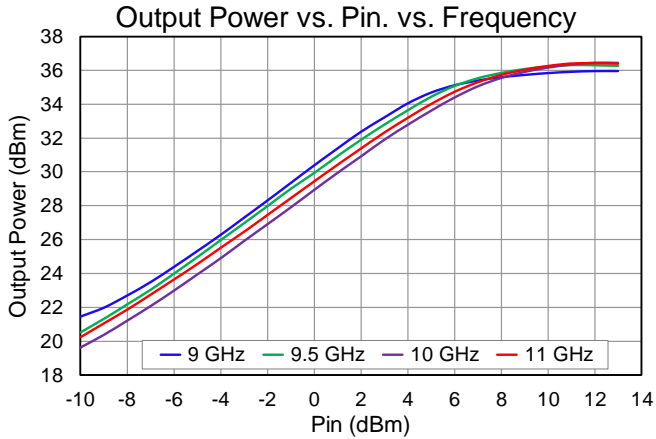
Performance Plots, Transmit Channel

Test Conditions unless otherwise stated: TXVD = 28 V, TXIDQ = 50 mA, TXVG fixed over temperature, RXSW = 0V  
TXSW = -28 V, Pin = 13 dBm, PW = 200uS, DC = 10%, LNA off. Data de-embedded to device reference plane, 25C



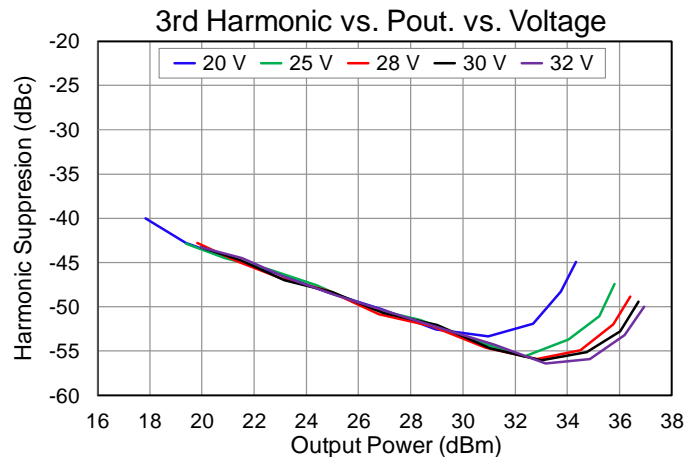
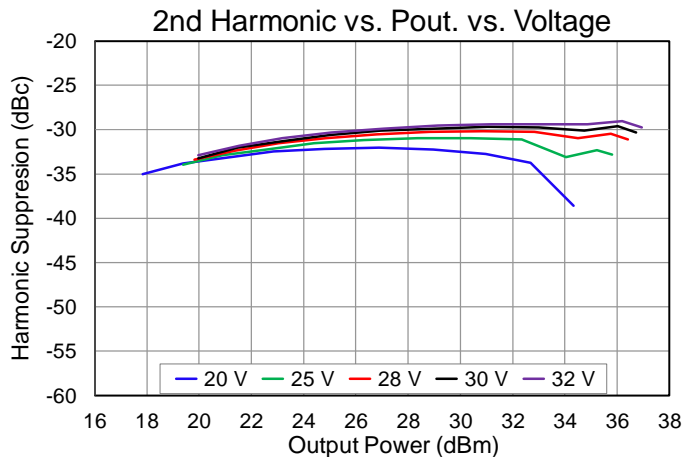
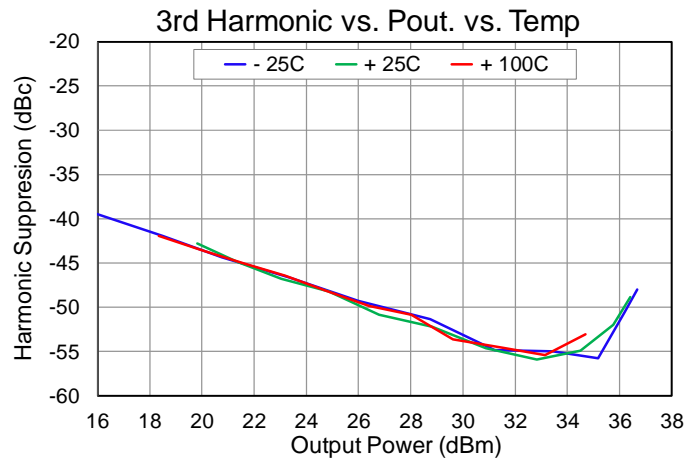
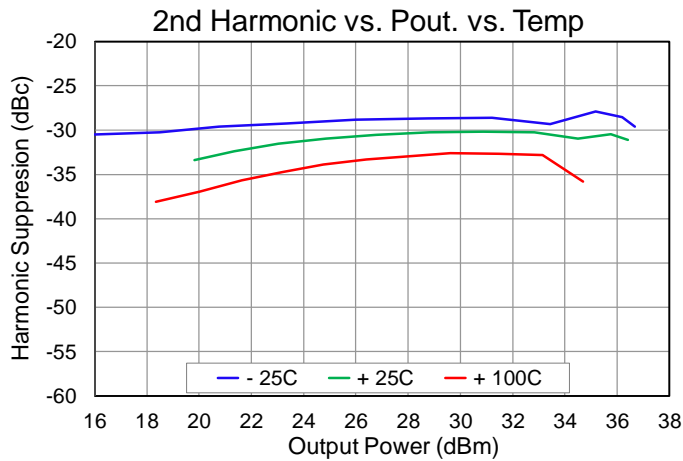
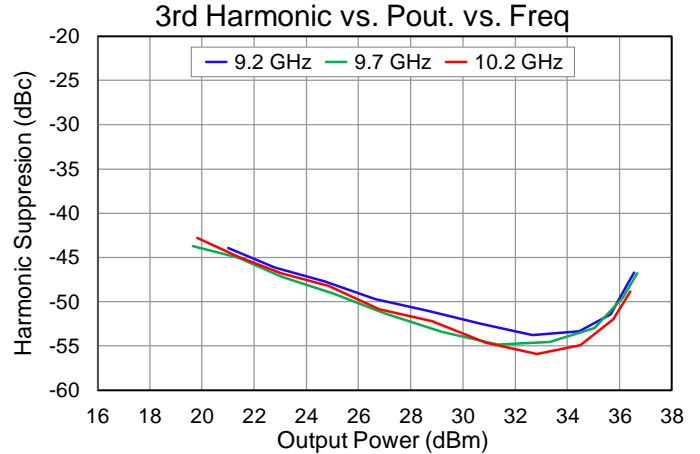
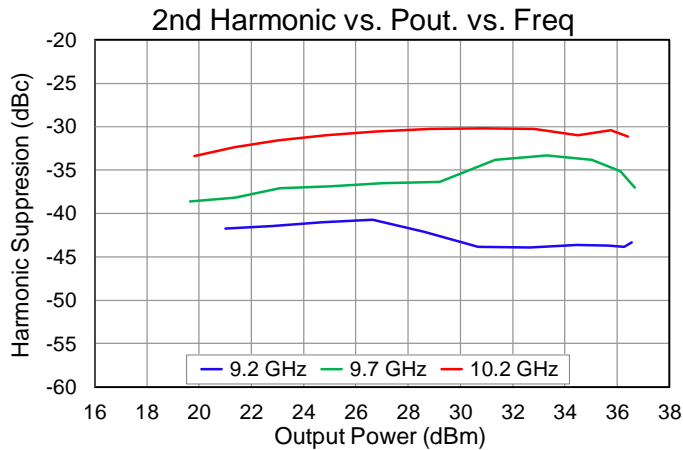
Performance Plots, Transmit Channel

Test Conditions unless otherwise stated: TXVD = 28 V, TXIDQ = 50 mA, RXSW = 0V, TXSW = -28 V  
PW = 200 uS, DC = 10%, LNA off. Data de-embedded to device reference plane, 25C

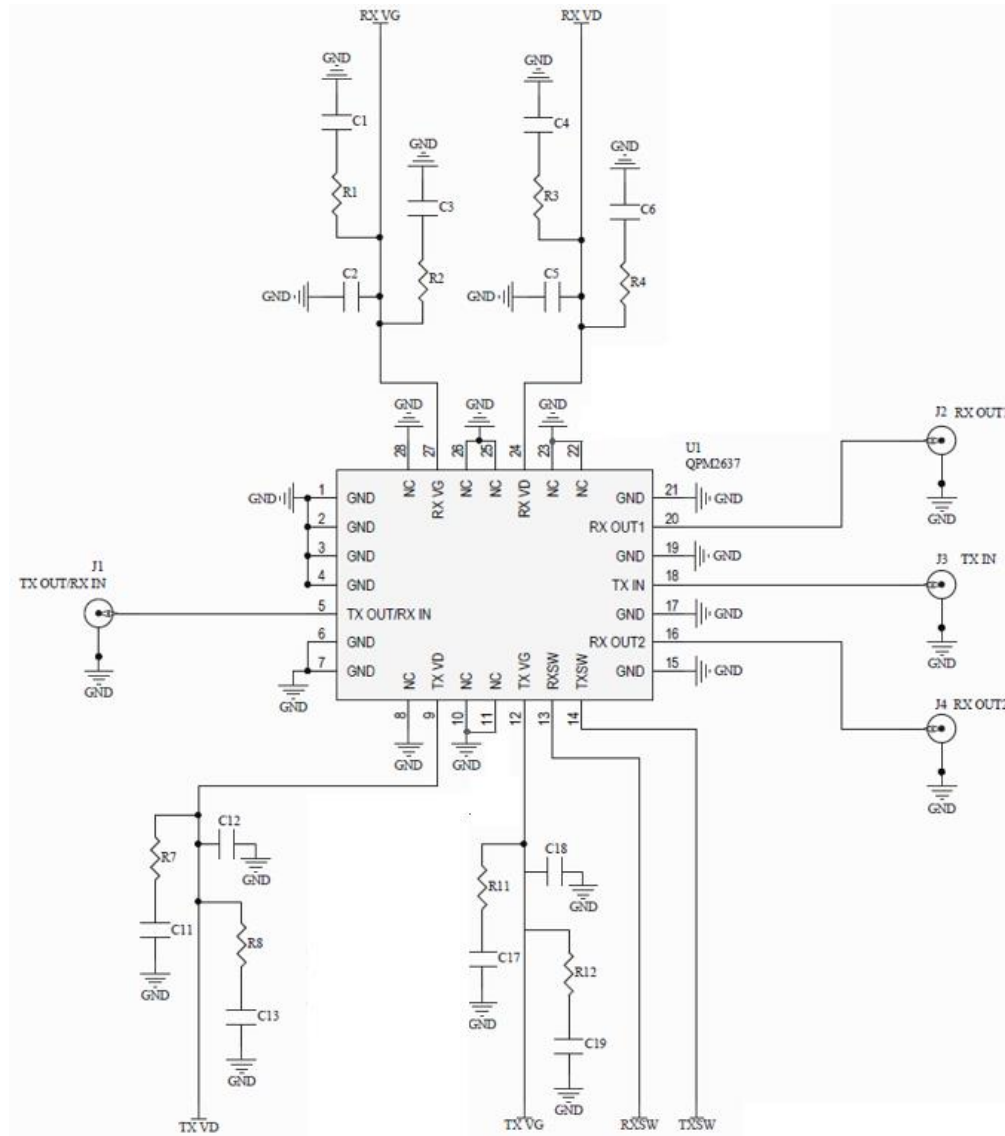


## Performance Plots, Transmit Channel

Test Conditions unless otherwise stated: TXVD = 28 V, TXIDQ = 50 mA, TXVG fixed over temperature  
RXSW = 0V, TXSW = -28 V, Freq: 10.2 GHz, LNA off. Data de-embedded to device reference plane, 25C



## Application Circuit



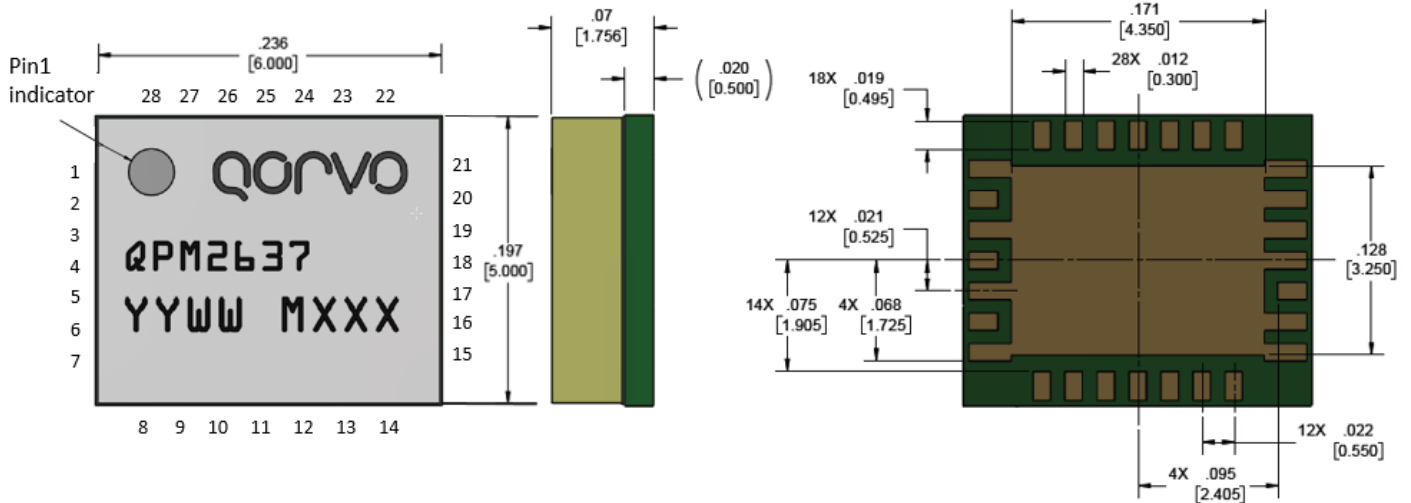
### Bias-up Procedure

1. Set TXVD current limit to 600 mA, RXVD current limit to 60 mA, RXVG current limit to 10 mA, TXVG current limit to 100 mA, switch control current limit to 10 mA
2. Set RXVG and TXVG to -5 V (TXVG will draw ~50mA current)
3. Set TXSW = -28 V (or 0 V), RXSW = 0 V (or -28 V) for TX (RX) channel operation
4. Set RXVD = +10 V, TXVD = +28 V
5. Adjust TXVG, RXVG to achieve required drain current for TX and RX (-2.5 V Typical)
6. Apply RF signal

### Bias-down Procedure

1. Turn off RF signal
2. Set RXVG, TXVG to -5 V
3. Set RXVD = 0 V, TXVD = 0 V
4. Turn off drain supply
5. Turn off TXSW, RXSW
6. Turn off gate supply

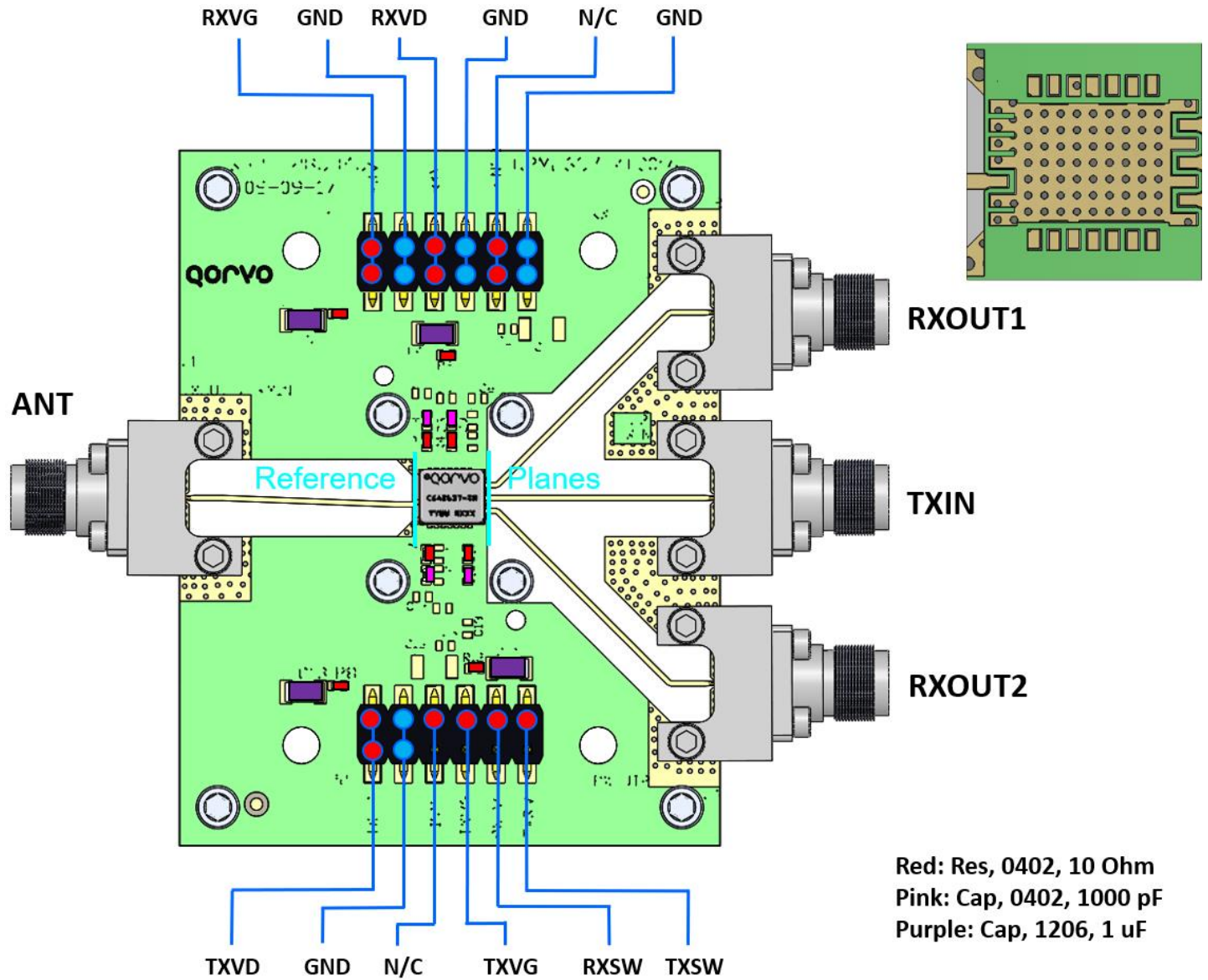
### Mechanical Drawing & Pad Description



Dimensions in mm. Package lead finish: Ni / Au plating with minimum gold thickness of 0.1 um  
 Part Marking: QPM2637: Part Number, YY = Part Assembly Year, WW = Part Assembly Week, MXXX = Batch ID

| Pin Number                             | Label  | Description                         |
|--|--------|-------------------------------------|
| 1, 2, 3, 4, 6, 7, 15, 17, 19, 21, Slug | GND    | GROUND                              |
| 5                                      | ANT    | Common Port to Antenna, DC Grounded |
| 9                                      | TXVD   | Transmit Drain Supply               |
| 12                                     | TXVG   | Transmit Gate Control               |
| 13                                     | RXSW   | Receive Switch Control              |
| 14                                     | TXSW   | Transmit Switch Control             |
| 16                                     | RXOUT2 | Receive Output 2, DC Blocked        |
| 18                                     | TXIN   | Transmit Input, DC Blocked          |
| 20                                     | RXOUT1 | Receive Output 1, DC Blocked        |
| 24                                     | RXVD   | Receive Drain Supply                |
| 27                                     | RXVG   | Receive Gate Control                |
| 8, 10, 11, 22, 23, 25, 26, 28          | N/C    | No Internal Connections             |

### Evaluation Board and Assembly



RF Layer is 0.008" thick Rogers Corp. RO4003C ( $\epsilon_r = 3.35$ ). Metal layers are 0.5 oz. copper. The microstrip line at the connector interface is optimized for the Southwest Microwave end launch connector 1492-04A-5.

| Ref. Des.                        | Component | Value                                     | Manuf.  | Part Number |
|----------------------------------|-----------|---|---------|-------------|
| C3, C6, C11, C17                 | SMT Cap.  | CAP, 0402 1000pF +/-10% 50V 0402 X7R ROHS | Various |             |
| C1, C4, C13, C19                 | SMT Cap.  | CAP, 1206 1.0uF +/-10% 50V X7R ROHS       | Various |             |
| R1, R2, R3, R4, R7, R8, R11, R12 | SMT Res.  | RES, 0402 10 OHM, 5% 50V, ROHS            | Various |             |

## Thermal and Reliability Information

| Parameter   | Values | Units | Conditions  |
|---|--------|-------|---|
| TX Channel, Thermal Resistance ( $\theta_{JC}$ ) <sup>(1,2)</sup> | 6.92   | °C/W  | T <sub>BASE</sub> = 100°C, TXVD = 28 V, TXIDQ =50 mA<br>TXID_DRIVE = 376 mA, P <sub>IN</sub> = 13 dBm,<br>Freq = 10GHz, P <sub>DISS</sub> = 6.60 W (PA only, LNA off) |
| Channel Temperature (T <sub>CH</sub> )                            | 145.70 | °C    |   |
| RX Channel, Thermal Resistance ( $\theta_{JC}$ ) <sup>(1)</sup>   | 12.37  | °C/W  | T <sub>BASE</sub> = 100°C, RXVD = 10 V, RXIDQ =30 mA<br>P <sub>DISS</sub> = 0.3 W (LNA only, PA off)  |
| Channel Temperature (T <sub>CH</sub> )                            | 103.71 | °C    |   |

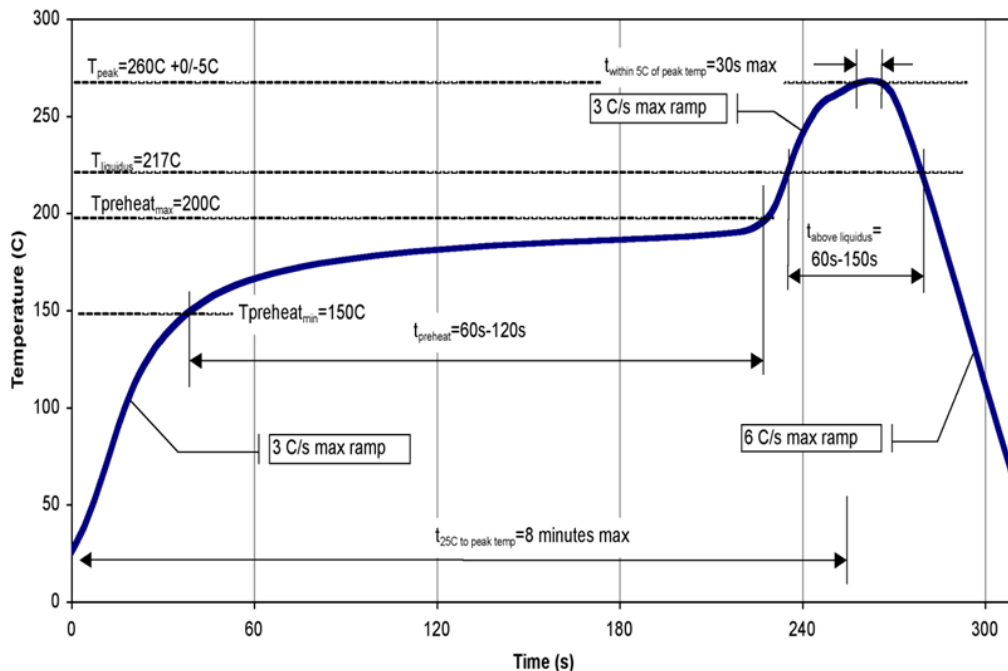
Notes:

- Thermal resistance is referenced to package backside.
- Transmit Channel, RF drive is under pulse drain supply condition, PW = 200 uS, DC = 10%, P<sub>DISS</sub> and I<sub>D\_DRIVE</sub> are peak values.
- Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#).

## Assembly Notes

- Compatible with both lead-free (260°C peak reflow temp.) and tin/lead (245°C peak reflow temp.) soldering processes.
- This package is air-cavity and non-hermetic, and therefore cannot be subjected to aqueous washing. The use of no-clean solder to avoid washing after soldering is highly recommended.
- Solder rework not recommended.

## Recommended Soldering Temperature Profile

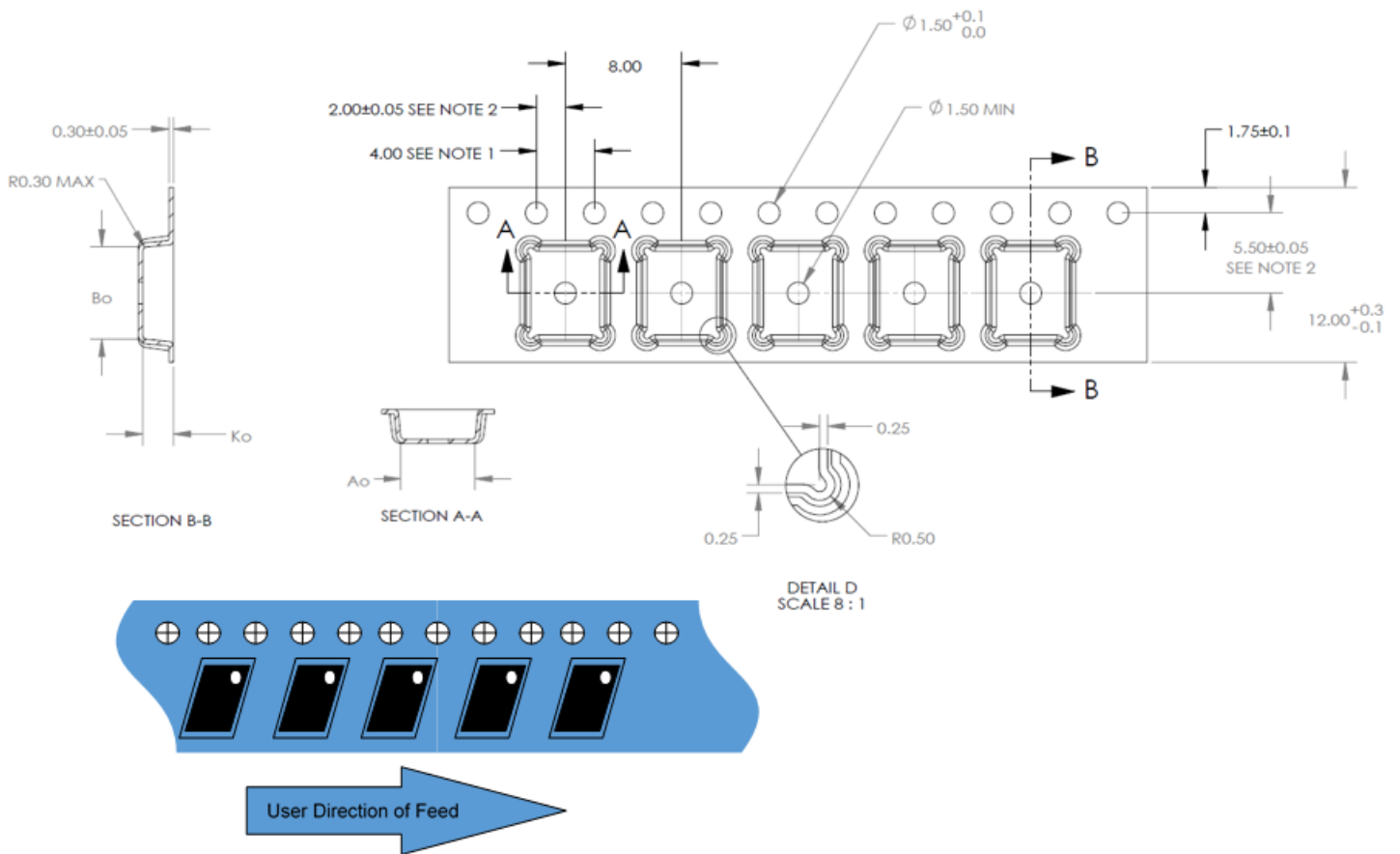




### Tape and Reel Information

Standard T/R size = 250 pieces on a 7" reel.

| Material |            | Cavity (mm) |            |            |            | Distance Between Centerline (mm) |                     | Carrier Tape (mm) | Cover Carrier (mm) |
|----------|------------|-------------|------------|------------|------------|----------------------------------|---------------------|-------------------|--------------------|
| Vendor   | Vendor P/N | Length (A0) | Width (B0) | Depth (K0) | Pitch (P1) | Length direction (P2)            | Width Direction (F) | Width (W)         | Width (W)          |
| Advantek | BCA389-A   | 5.30        | 6.30       | 2.1        | 8.0        | 2.00                             | 5.50                | 12.0              | 9.20               |



## Handling Precautions

| Parameter                        | Rating | Standard                           |
|----------------------------------|--------|------------------------------------|
| ESD – Human Body Model (HBM)     | TBD    | ESDA / JEDEC JS-001-2012           |
| ESD – Charged Device Model (CDM) | TBD    | ESDA / JEDEC JS-002-2014           |
| MSL – Convection Reflow 260 °C   | TBD    | JEDEC standard IPC/JEDEC J-STD-020 |



Caution!  
ESD-Sensitive Device

## RoHS Compliance

This product is compliant with the 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment), as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Antimony Free
- TBBP-A (C<sub>15</sub>H<sub>12</sub>Br<sub>4</sub>O<sub>2</sub>) Free
- PFOS Free

## Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations:

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**Web:** [www.qorvo.com](http://www.qorvo.com)

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